



Sample &

Buv





SCES205L-APRIL 1999-REVISED DECEMBER 2014

# SN74LVC2G126 Dual Bus Buffer Gate With 3-State Outputs

Technical

Documents

#### 1 Features

- Available in the Texas Instruments NanoFree™ Package
- Supports 5-V V<sub>CC</sub> Operation
- Inputs Accept Voltages to 5.5 V
- Max  $t_{pd}$  of 4ns at 3.3V
- Low Power Consumption, 10-µA Max I<sub>CC</sub>
- ±24-mA Output Drive at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 0.8 V at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C
- Typical V<sub>OHV</sub> (Output VOH Undershoot) > 2 V at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C
- Ioff Supports Live Insertion, Partial-Power-Down Mode, and Back-Drive Protection
- Can Be Used as a Down Translator to Translate Inputs From a Max of 5.5 V Down to the V<sub>CC</sub> Level
- Latch-Up Performance Exceeds 100 mA Per • JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model
  - 200-V Machine Model
  - 1000-V Charged-Device Model

## 2 Applications

Tools &

Software

- Cable Modem Termination Systems
- High-Speed Data Acquisition and Generation

Support &

Community

- Military: Radars and Sonars
- Motor Controls: High-Voltage
- Power Line Communication Modems
- SSDs: Internal or External
- Video Broadcasting and Infrastructure: Scalable Platforms
- Video Broadcasting: IP-Based Multi-Format Transcoders
- Video Communication Systems

## 3 Description

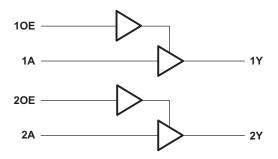
These bus transceivers are designed for 1.65-V to 3.6-V V<sub>CC</sub> operation. The SN74LVC2G126 device is a dual line driver with 3-state output. The output is disabled when the output-enable input is low.

## Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE		
	SM8 (8)	2.95 mm × 2.80 mm		
SN74LVC2G126	US8 (8)	2.30 mm × 2.00 mm		
	DSBGA (8)	1.91 mm × 0.91 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### 4 Simplified Schematic



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## **5** Revision History

Cł	nanges from Revision K (November 2013) to Revision L	Page
•	Added Applications, Device Information table, ESD Ratings table, Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.	1
	mornation section.	1
•	Updated Features	1

## Changes from Revision J (January 2007) to Revision K

•	Deleted Ordering Information table.	1
•	Updated operating temperature range	5
•	Added ESD warning	12

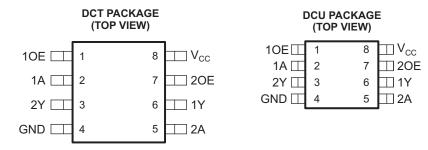
NSTRUMENTS

**FEXAS** 

Page



## 6 Pin Configuration and Functions



See mechanical drawings for dimensions.

	PACK/	
GND	O4 50	2A
2Y	O36O	1Y
1A	O2 70	20E
10E	O1 80	$V_{\rm CC}$

See mechanical drawings for dimensions.

## **Pin Functions**

PIN        NO.      NAME        1      OE1        2      1A        3      2Y	PIN TYPE		DESCRIPTION					
NO.	NAME	ITE	DESCRIPTION					
1	OE1	I	OE1 Enable/Input					
2	1A	I	1A Input					
3	2Y	0	2Y Output					
4	GND	—	Ground Pin					
5	2A	I	2A Input					
6	1Y	0	1Y Output					
7	20E	I	20E Enable/Input					
8	V <sub>CC</sub>	_	Power Pin					

## 7 Specifications

## 7.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	6.5	V
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Voltage range applied to any output in the high-impedance or	power-off state <sup>(2)</sup>	-0.5	6.5	V
Vo	Voltage range applied to any output in the high or low state $^{(2)}$	(3)	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	/ <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	/ <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) The value of  $V_{CC}$  is provided in the *Recommended Operating Conditions* table.

## 7.2 ESD Ratings

	PARAMETER	DEFINITION	VALUE	UNIT
V	Electrostatic	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	2000	V
V <sub>(ESD)</sub>	discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	1000	v

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT	
V	Supply voltage	Operating	1.65	5.5	V	
V <sub>CC</sub>	Supply voltage	Data retention only	1.5		v	
		V <sub>CC</sub> = 1.65 V to 1.95 V 0.6				
V		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
VIH	High-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$	2		V	
		$V_{CC} = 4.5 V$ to 5.5 V	$0.7 \times V_{CC}$			
		$V_{CC} = 1.65 \text{ V} \text{ to } 1.95 \text{ V}$		$0.35 \times V_{CC}$		
V		V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	V	
V <sub>IL</sub>	Low-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$		0.8	V	
		$V_{CC} = 4.5 V \text{ to } 5.5 V$		$0.3 \times V_{CC}$		
VI	Input voltage		0	5.5	V	
V <sub>I</sub> V <sub>O</sub>	Output voltogo	High or low state	0	V <sub>CC</sub>	V	
	Output voltage	3-state	0	5.5	V	
		V <sub>CC</sub> = 1.65 V				
		V <sub>CC</sub> = 2.3 V		-8	mA	
I <sub>OH</sub>	High-level output current	High-level output current		-16		
		$V_{CC} = 3 V$		-24		
		V <sub>CC</sub> = 4.5 V		-32		
		V <sub>CC</sub> = 1.65 V		4		
		V <sub>CC</sub> = 2.3 V		8		
I <sub>OL</sub>	Low-level output current	<u> </u>		16	mA	
		$V_{CC} = 3 V$		24		
		V <sub>CC</sub> = 4.5 V		32		
		$V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}, 2.5 \text{ V} \pm 0.2 \text{ V}$		20		
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		10	ns/V	
		$V_{CC} = 5 V \pm 0.5 V$		5		
T <sub>A</sub>	Operating free-air temperature		-40	125	°C	

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## 7.4 Thermal Information

	THERMAL METRIC <sup>(1)</sup>	DCT (8 PINS)	DCU (8 PINS)	YZP (8 PINS)	UNIT
R <sub>0JA</sub> Junctio	n-to-ambient thermal resistance	220	227	102	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

## SN74LVC2G126

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## 7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	v	T <sub>A</sub> = 25°C		–40°C to 85°C		-40°C to 125°C		UNIT		
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup> I	МАХ	MIN	MAX	MIN	MAX	UNIT	
	I <sub>OH</sub> = -100 μA	1.65 V to 5.5 V	V <sub>CC</sub> - 0.1			V <sub>CC</sub> - 0.1		V <sub>CC</sub> - 0.1			
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.2			1.2		1.2			
V <sub>OH</sub>	I <sub>OH</sub> = -8 mA	2.3 V	1.9			1.9		1.9		V	
	$I_{OH} = -16 \text{ mA}$	3 V	2.4			2.4		2.4			
	$I_{OH} = -24 \text{ mA}$	3 V	2.3			2.3		2.3			
	$I_{OH} = -32 \text{ mA}$	4.5 V	3.8			3.8		3.8			
	I <sub>OL</sub> = 100 μA	1.65 V to 5.5 V			0.1		0.1		0.1		
V <sub>OL</sub>	I <sub>OL</sub> = 4 mA	1.65 V			0.45		0.45		0.45		
	I <sub>OL</sub> = 8 mA	2.3 V			0.3		0.3		0.3		
	I <sub>OL</sub> = 16 mA	2.1/			0.4		0.4		0.4		
	I <sub>OL</sub> = 24 mA	3 V			0.55		0.55		0.55		
	I <sub>OL</sub> = 32 mA	4.5 V			0.55		0.55		0.75		
II A or OE inputs	V <sub>1</sub> = 5.5 V or GND	0 to 5.5 V			±5		±5		±5	μA	
l <sub>off</sub>	$V_1 \text{ or } V_0 = 5.5 \text{ V}$	0			±10		±10		±10	μA	
I <sub>OZ</sub>	V <sub>O</sub> = 0 to 5.5 V	3.6 V			10		10		10	μA	
I <sub>CC</sub>	$V_{\rm I} = 5.5 \text{ V or GND}$ $I_{\rm O} = 0$	1.65 V to 5.5 V			10		10		10	μA	
ΔI <sub>CC</sub>	One input at $V_{CC} - 0.6 V$ , Other inputs at $V_{CC}$ or GND	3 V to 5.5 V			500		500		500	μA	
C <sub>1</sub> Data inputs	$V_1 = V_{CC}$ or GND	3.3 V		3.5						pF	
Control inputs		3.3 V		4						μL	
Co	V <sub>O</sub> = V <sub>CC</sub> or GND	3.3 V		6.5						pF	

(1) All typical values are at  $V_{CC} = 3.3$  V,  $T_A = 25^{\circ}C$ .

## 7.6 Switching Characteristics, –40°C to 85°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

						–40°C t	o 85°C				
PARAMETER	PARAMETER FROM (INPUT)		V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 5 V ± 0.5 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	A	Y	3.5	9.8	1.7	4.9	1.4	4	1	3.2	ns
t <sub>en</sub>	OE	Y	3.5	10	1.7	5	1.5	4.1	1	3.1	ns
t <sub>dis</sub>	OE	Y	1.7	12.6	1	5.7	1	4.4	1	3.3	ns

## 7.7 Switching Characteristics, -40°C to 125°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

		TO (OUTPUT)	–40°C to 125°C									
PARAMETER	FROM (INPUT)		V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2 ± 0.2		V <sub>CC</sub> = 3 ± 0.3		V <sub>CC</sub> = 5 V ± 0.5 V		UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
t <sub>pd</sub>	А	Y	3.5	10.8	1.7	5.9	1.4	5	1	3.7	ns	
t <sub>en</sub>	OE	Y	3.5	11	1.7	6	1.5	5.1	1	3.6	ns	
t <sub>dis</sub>	OE	Y	1.7	13.6	1	6.7	1	5.4	1	3.8	ns	

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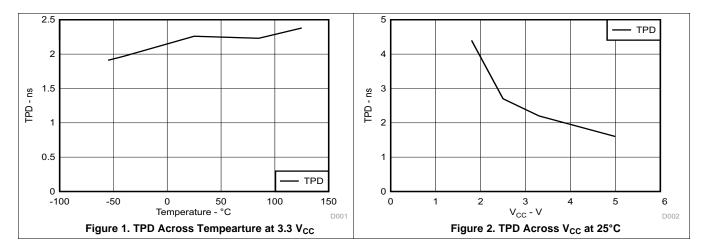
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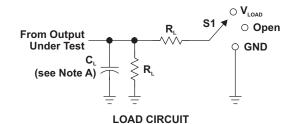
## 7.8 Operating Characteristics

$T_A = 2$	5°								
	DADAMETER		TEST	V <sub>CC</sub> = 1.8 V V <sub>CC</sub> = 2.5 V		$V_{CC} = 3.3 V$	$V_{CC} = 5 V$	UNIT	
PARAMETER			CONDITIONS	ТҮР	TYP	ТҮР	TYP	UNIT	
C	Power dissipation	Outputs enabled	f = 10 MHz	19	19	20	22	۶E	
C <sub>pd</sub>	capacitance	Outputs disabled		2	2	2	3	pF	

## 7.9 Typical Characteristics

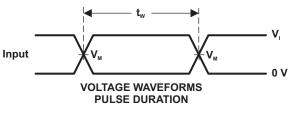


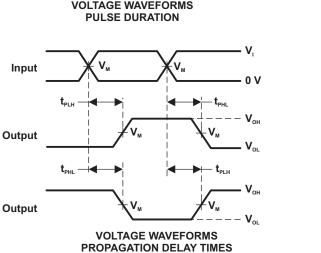
## 8 Parameter Measurement Information



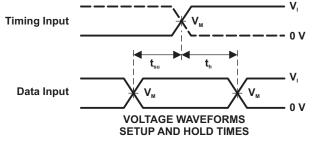
TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
$t_{PLZ}/t_{PZL}$	VLOAD
$t_{_{PHZ}}/t_{_{PZH}}$	GND

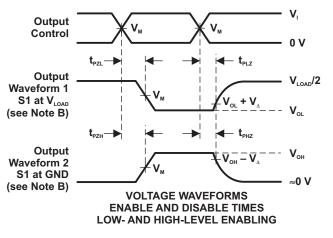
	INF	PUTS	V	V	•	1	N	
V <sub>cc</sub>	V	t,/t,	V <sub>M</sub>	VLOAD	C	R	$V_{\Delta}$	
1.8 V ± 0.15 V	V <sub>cc</sub>	≤2 ns	V <sub>cc</sub> /2	2 × V <sub>cc</sub>	30 pF	<b>1 k</b> Ω	0.15 V	
$2.5~V\pm0.2~V$	$V_{cc}$	≤2 ns	V <sub>cc</sub> /2	2 × V <sub>cc</sub>	30 pF	<b>500</b> Ω	0.15 V	
$3.3 V \pm 0.3 V$	3 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	
$5 V \pm 0.5 V$	$V_{cc}$	≤2.5 ns	V <sub>cc</sub> /2	2 × V <sub>cc</sub>	50 pF	<b>500</b> Ω	0.3 V	





INVERTING AND NONINVERTING OUTPUTS





NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z₀ = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

## Figure 3. Load Circuit and Voltage Waveforms



#### Detailed Description 9

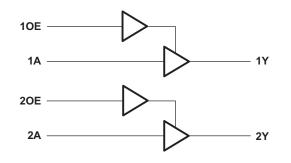
## 9.1 Overview

The SN74LVC2G126 device contains a dual buffer gate with output enable control and performs the Boolean function Y = A.

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power up or power down, OE should be tied to  $V_{CC}$  through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

## 9.2 Functional Block Diagram



## 9.3 Feature Description

- 1.65 V to 5.5 V operating voltage range
- Allows down voltage translation
  - 5 V to 3.3V
  - 5 V or 3.3 V to 1.8V
- Inputs accept voltages to 5.5 V
  - 5-V tolerance on input pin
- I<sub>off</sub> feature
  - Allows voltage on the inputs and outputs when V<sub>CC</sub> is 0 V
  - Able to prevent leakage when  $V_{CC}$  is 0 V

## 9.4 Device Functional Modes

## **Table 1. Function Table**

INP	UTS	OUTPUT
OE	Α	Y
Н	Н	Н
н	L	L
L	Х	Z

## **10** Application and Implementation

## **10.1** Application Information

The SN74LVC2G126 device is a high-drive CMOS device that can be used as an output enabled buffer with a high output drive, such as an LED application. It can produce 24 mA of drive current at 3.3 V, making it ideal for driving multiple outputs and good for high speed applications up to 100 MHz. The inputs are 5.5-V tolerant allowing it to translate down to  $V_{CC}$ .

## **10.2 Typical Application**

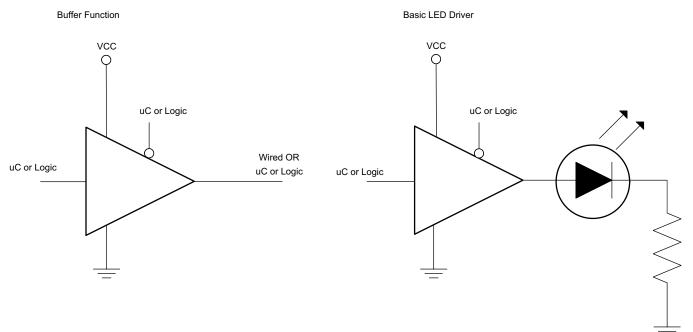


Figure 4. Application Schematic

## **10.2.1** Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. Outputs can be combined to produce higher drive but the high drive will also create faster edges into light loads so routing and load conditions should be considered to prevent ringing.

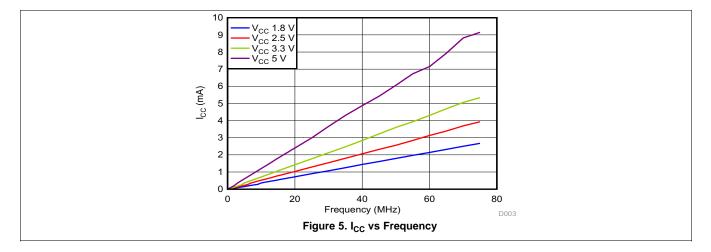
## 10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions:
  - For rise time and fall time specifications, see  $\Delta t/\Delta V$  in the *Recommended Operating Conditions* table.
  - For specified high and low levels, see V<sub>IH</sub> and V<sub>IL</sub> in the *Recommended Operating Conditions* table.
  - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid  $V_{CC}$ .
- 2. Recommend Output Conditions:
  - Load currents should not exceed 50 mA per output and 100 mA total for the part.



## **Typical Application (continued)**

## 10.2.3 Application Curves



## **11 Power Supply Recommendations**

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each V<sub>CC</sub> terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1  $\mu$ F capacitor is recommended. If there are multiple V<sub>CC</sub> terminals then 0.01  $\mu$ F or 0.022  $\mu$ F capacitors are recommended for each power terminal. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. Multiple bypass capacitors may be paralleled to reject different frequencies of noise. The bypass capacitor should be installed as close to the power terminal as possible for the best results.

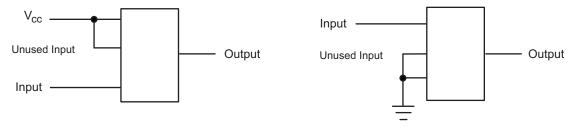
## 12 Layout

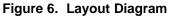
## 12.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 6 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the I/Os so they also cannot float when disabled.

## 12.2 Layout Example





13 Device and Documentation Support

13.2 Electrostatic Discharge Caution

All trademarks are the property of their respective owners.

SLYZ022 — TI Glossary.

13.1 Trademarks

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13.3 Glossary

# 14 Mechanical, Packaging, and Orderable Information

This glossary lists and explains terms, acronyms and definitions.

during storage or handling to prevent electrostatic damage to the MOS gates.

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam

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## TEXAS INSTRUMENTS



13-Jun-2014

## PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
74LVC2G126DCTRG4	ACTIVE	SM8	DCT	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	C26 Z	Samples
74LVC2G126DCUTE4	ACTIVE	US8	DCU	8		TBD	Call TI	Call TI	-40 to 125		Samples
74LVC2G126DCUTG4	ACTIVE	US8	DCU	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	C26R	Samples
SN74LVC2G126DCTR	ACTIVE	SM8	DCT	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	C26 Z	Samples
SN74LVC2G126DCUR	ACTIVE	US8	DCU	8	3000	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 125	(C26Q ~ C26R)	Samples
SN74LVC2G126DCUT	ACTIVE	US8	DCU	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 125	(C26Q ~ C26R)	Samples
SN74LVC2G126YZPR	ACTIVE	DSBGA	YZP	8	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	(CN7 ~ CNN)	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



# PACKAGE OPTION ADDENDUM

13-Jun-2014

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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### OTHER QUALIFIED VERSIONS OF SN74LVC2G126 :

Enhanced Product: SN74LVC2G126-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

# **PACKAGE MATERIALS INFORMATION**

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## **TAPE AND REEL INFORMATION**





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74LVC2G126DCUTG4	US8	DCU	8	250	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3
SN74LVC2G126DCUR	US8	DCU	8	3000	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3
SN74LVC2G126YZPR	DSBGA	YZP	8	3000	178.0	9.2	1.02	2.02	0.63	4.0	8.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

18-Aug-2014



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
74LVC2G126DCUTG4	US8	DCU	8	250	202.0	201.0	28.0
SN74LVC2G126DCUR	US8	DCU	8	3000	202.0	201.0	28.0
SN74LVC2G126YZPR	DSBGA	YZP	8	3000	220.0	220.0	35.0

# **MECHANICAL DATA**

MPDS049B - MAY 1999 - REVISED OCTOBER 2002

## DCT (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion

D. Falls within JEDEC MO-187 variation DA.



DCT (R-PDSO-G8) PLASTIC SMALL OUTLINE Example Board Layout Example Stencil Design (Note C,E) (Note D) - 6x0,65 - 6x0,65 8x0,25-8x1,55 3,40 3,40 Non Solder Mask Defined Pad Example Pad Geometry -0,30 (Note C) 1,60 Example -0,07 Non-solder Mask Opening All Around (Note E) 4212201/A 10/11

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

D. Falls within JEDEC MO-187 variation CA.



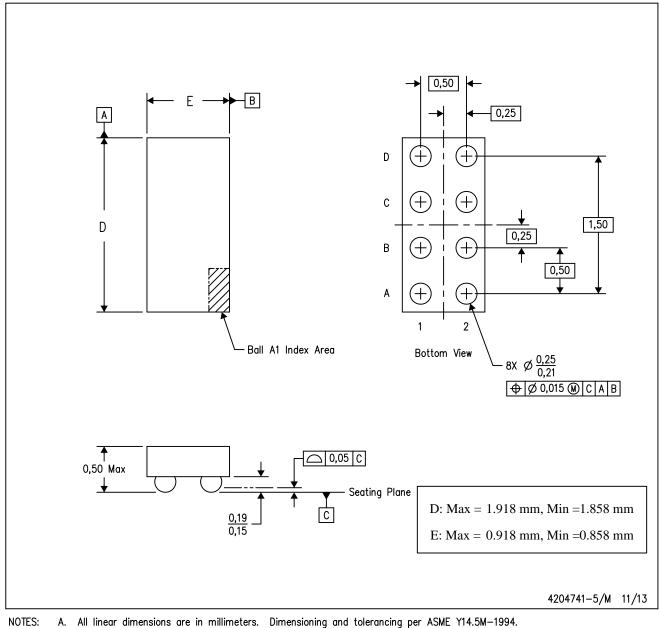


- NOTES: A. All linear dimensions are in millimeters. В. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



YZP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



- A. All linear dimensions are in millimeters. Dimension B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.

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